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## Theory of Spin Loss at Metallic Interfaces

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Interfacial spin-flip scattering plays an important role in magnetoelectronic devices. Spin loss at metallic interfaces is usually quantified by matching the magnetoresistance data for multilayers to the Valet-Fert model, while treating each interface as a fictitious bulk layer whose thickness is  $\delta$  times the spin-diffusion length. By employing the properly generalized circuit theory and the scattering matrix approaches, we derive the relation of the parameter  $\delta$  to the spin-flip transmission and reflection probabilities at an individual interface. It is found that  $\delta$  is proportional to the square root of the probability of spin-flip scattering. We calculate the spin-flip scattering probabilities for flat and rough Cu/Pd interfaces using the Landauer-Büttiker method based on the first-principles electronic structure and find  $\delta$  to be in reasonable agreement with experiment.

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Spin transport at metallic interfaces is an essential ingredient of various spintronic device concepts, such as giant magnetoresistance (GMR) [1–3], spin injection and accumulation [4], spin-transfer torque [5], and spin pumping [6]. Spin-orbit coupling (SOC) enables some device concepts, such as spin-orbit torques in ferromagnet/heavy-metal bilayers [7,8] and spin current detection based on the inverse spin-Hall effect [9] in spin-caloritronic devices [10]. Interfacial spin-orbit scattering affects spin transport in GMR multilayers [2,3], spin pumping [11,12], spin injection [13], and Gilbert damping [14]. It contributes to the spin relaxation in metallic films [15–17] and to the magnetoanisotropies in the resistance of magnetic multilayers [18], tunneling conductance [19–22], and Andreev reflection [23,24], which are especially large when the magnetic electrodes are half-metallic [24,25]. Interfacial spin-flip scattering can also appear due to spin fluctuations [26].

In the absence of interfacial spin-flip scattering, spin transport in magnetoelectronic circuits can usually be described using the circuit theory [27–29]. In the presence of SOC, the spin current is not conserved at the interfaces. Absent a complete theory, interfacial spin-flip scattering has been described by introducing a fictitious bulk layer of thickness  $t_I$ , resistivity  $\rho_I$ , and spin-diffusion length  $l_{sf}^I$ , and using the parameter  $\delta = t_I/l_{sf}^I$  to characterize “spin memory loss” at the interface [2,3,14,30,31]. The parameter  $\delta$  was measured [2,3] for multiple interfaces by mapping the experimental current-perpendicular-to-the-plane magnetoresistance data, for spin valves with multilayer insertions, to the phenomenological Valet-Fert model [32]. However, the relation of the parameter  $\delta$  to the scattering properties of an individual interface is not known. Moreover, this description of an interface is

generally incomplete because the spin-flip transmittance and the reflectances on two sides are all independent parameters. For example, the spin-flip reflectance is relevant for spin injection [33] and for the interface-induced spin relaxation in a spin reservoir [15–17]. The existing formulations [13,34,35] including only one interfacial spin-relaxation parameter are, therefore, also incomplete.

In this Letter we apply the scattering matrix and the generalized circuit theory approaches to establish the correspondence between the phenomenological parameter  $\delta$  for a nonmagnetic interface, as extracted from GMR-like measurements, and the calculable spin-resolved transmittance and reflectance properties of an individual interface. The latter are calculated from first principles for the Cu/Pd interface. The theory provides a complete framework for including interfacial spin-flip scattering in magnetoelectronic devices.

*Valet-Fert theory.*—The layer thicknesses in the typical measurements [2,3] are about 3 nm; the resistance of each individual layer is at least a few times smaller than the resistance of each interface, as long as nominally pure materials are used. For example, the area-resistance products of a 3-nm layer of nominally pure Pd and of the Cu/Pd interface are about 0.14 and 0.45 f $\Omega$ m<sup>2</sup>, respectively [2]. Therefore, in the following we treat the problem under the assumption that the bulk resistances are negligibly small compared to the interface resistances. This simplifies the expressions and does not affect the result to first order in spin-flip scattering rates [36].

To facilitate comparison with scattering theory, it is convenient to consider a periodic multilayer in which the  $FN_1(N_2N_1)_N$  block repeats itself. Here,  $F$  is a ferromagnetic layer,  $N_1$  and  $N_2$  are two different nonmagnetic layers, and we are interested in the properties of the  $N_1/N_2$

interface. Describing an interface as a bulk interlayer, we solve the Valet-Fert equations [32] in the multilayer for parallel and alternating antiparallel configurations using the transfer-matrix approach. Taking the limit in which the resistance is dominated by and spin-flip scattering is present only at  $N_1/N_2$  interfaces, we find a simple expression for the magnetoresistance:

$$\Delta R = R_{AP} - R_P = \frac{(\beta r_F^*)^2}{r_I} \frac{\delta}{\sinh m\delta}, \quad (1)$$

where  $m = 2\mathcal{N}$  is the number of interfaces,  $\beta = (\rho_\downarrow - \rho_\uparrow)/(\rho_\uparrow + \rho_\downarrow)$  the spin asymmetry,  $r_F^* = \rho_F^* t_F$  the effective resistance,  $t_F$  the thickness, and  $\rho_F^* = (\rho_\uparrow + \rho_\downarrow)/4$  the effective resistivity of the ferromagnet, and  $r_I = \rho_I t_I$  is the resistance of the interface.

*Scattering theory.*—Since we are dealing with low-resistance metallic interfaces, the relevant resistances are those measured in the two-terminal setup, rather than the four-terminal resistances measured in a constriction or calculated within the Landauer-Büttiker approach. For spin-conserving interfaces, the relation between the two is well known [37]: the interface resistance appearing in series-resistor expressions is obtained from the Landauer-Büttiker resistance by subtracting the spurious contribution of the Sharvin resistance. The approach of Ref. [37], which takes into account the deviations of the distribution functions from equilibrium, can be readily applied to the periodic multilayer introduced above.

We use the result of Ref. [37] for the two-terminal conductance  $G^S$ :

$$G^S = 2G_0 \sum_{ij\sigma\sigma'} [(I - T + R)^{-1} T]_{ij\sigma\sigma'}, \quad (2)$$

where  $i, j$  denote conduction channels,  $G_0 = e^2/h$ , and the transmission and reflection matrices  $T$  and  $R$  are now  $2 \times 2$  in spin space. The transmission and reflection matrices are calculated using the semiclassical concatenation rules [38]. The irrelevant spin-flip scattering in the ferromagnetic layers is neglected, and the spin-diagonal transmission and reflection matrices across half of the ferromagnetic layer are written as

$$T_{i\sigma,j\sigma'}^F = \frac{1}{M_1} \frac{\delta_{\sigma\sigma'}}{1 + s_\sigma}, \quad R_{i\sigma,j\sigma'}^F = \frac{1}{M_1} \frac{s_\sigma \delta_{\sigma\sigma'}}{1 + s_\sigma}, \quad (3)$$

where  $M_1$  is the number of conducting channels per spin in the adjacent normal metal, and  $s_\sigma = r_\sigma M_1/2$ , where  $r_\sigma$  is the resistance of one spin channel (which includes the  $F/N$  interface resistance). The factor  $\frac{1}{2}$  comes from the fact that the supercell period contains half of the  $F$  layer at each edge. Concatenation of two such “half-thick”  $F$  layers leads to the correct scattering matrices for the whole  $F$  layer. The results of this calculation are identical to those of the circuit theory, Eqs. (6) and (7).

*Circuit theory.*—A more general approach, not limited to periodic structures, is to employ the magnetoelectronic circuit theory [27–29] extended to include spin-flip scattering [36]. For an adjacent pair of layers  $L_1, L_2$  in a magnetic multilayer, the charge  $I^0$  and spin  $\vec{I}^s$  currents in, say, layer  $L_2$  are

$$I_2^0 = G\Delta f^0 + \vec{G}^s \Delta \vec{f}^s - \vec{G}^t \cdot \vec{f}_1^s - \vec{G}^r \cdot \vec{f}_2^s, \quad (4)$$

$$\vec{I}_2^s = \vec{G}^s \Delta f^0 + G\Delta \vec{f}^s - \hat{\mathcal{G}}^t \cdot \vec{f}_1^s - \hat{\mathcal{G}}^r \cdot \vec{f}_2^s. \quad (5)$$

Here,  $\Delta f^0 = f_1^0 - f_2^0$  and  $\Delta \vec{f}^s = \vec{f}_1^s - \vec{f}_2^s$  are interfacial drops of charge and spin components of the distribution function. We introduced 28 parameters, including one scalar charge conductance  $G$ , three vector conductances  $\vec{G}^s, \vec{G}^t$ , and  $\vec{G}^r$ , and two tensor conductances  $\hat{\mathcal{G}}^t$  and  $\hat{\mathcal{G}}^r$  (see the Supplemental Material [36] for their definitions and relation to the notation used in Ref. [39]). Equations (4) and (5) represent the most general form of the boundary conditions; in particular, they include the effects of the mixing conductances, which are important in noncollinear magnetic multilayers [40–42]. They also reproduce the generalization of Valet-Fert theory to noncollinear systems [43,44].

The expressions simplify for a nonmagnetic, axially symmetric interface, for which  $\vec{G}^s = \vec{G}^t = \vec{G}^r = 0$ , and the tensors  $\hat{\mathcal{G}}^t$  and  $\hat{\mathcal{G}}^r$  are diagonal in the axial reference frame. For highly transparent interfaces, all conductances should be properly renormalized [45,46]; the expressions are given in the Supplemental Material [36].

We apply the circuit theory to the  $FN_1(N_2N_1)_NF$  spin valve, using Kirchhoff’s rules for charge and spin conservation in each node. For simplicity, we assume that the spin accumulation is aligned parallel or perpendicular to the interface; the general case can be treated as a superposition of these alignments. Retaining only first-order terms in spin-flip scattering at each concatenation step, we find the magnetoresistance

$$\Delta R = \frac{(\beta r_F^*)^2}{\tilde{r}_I m} \left( 1 - \frac{\tilde{G}^t}{G} - (m^2 - 1) \frac{2\tilde{G}^t + \tilde{G}_1^t + \tilde{G}_2^t}{6\tilde{G}} \right), \quad (6)$$

where the tilde accentuates the renormalized conductances [36] for the given spin accumulation axis (for example,  $2G_0/\tilde{G} = 2G_0/G - 1/2M_1 - 1/2M_2$  [37]). Before renormalization,  $G = G_0(T_{\uparrow\uparrow} + T_{\downarrow\downarrow} + T_{\uparrow\downarrow} + T_{\downarrow\uparrow})$ ,  $\mathcal{G}^t = 2G_0(T_{\uparrow\downarrow} + T_{\downarrow\uparrow})$ , and  $\mathcal{G}_i^t = 2G_0(R_{\uparrow\downarrow}^i + R_{\downarrow\uparrow}^i)$  corresponds to reflectance with incidence from metal  $N_i$ . When the number of layers is large, we can neglect  $m$ -independent spin-flip terms and rewrite (6) as

$$\Delta R_{\parallel(\perp)} = \frac{(\beta r_F^*)^2}{\tilde{r}_I m} \left[ 1 - \frac{1}{3} m^2 \frac{\mathcal{G}_{\parallel(\perp)}^{\text{sl}}}{G} \right], \quad (7)$$

where  $\tilde{r}_I = \tilde{G}^{-1}$  is the renormalized interface resistance, and we also introduced the *spin-loss conductance*

$\mathcal{G}^{\text{sl}} = \mathcal{G}^t + (\mathcal{G}_1^r + \mathcal{G}_2^r)/2$ . Note that  $\mathcal{G}^{\text{sl}}$  does not need to be renormalized by the Sharvin resistance when calculated up to the first order in the spin-flip processes.

To establish correspondence with the Valet-Fert model, we note that, to second order in  $x$ , we have  $x/\sinh x \approx (1 - x^2/6)$ . Relating Eqs. (7) and (1), we find

$$\delta^2 = 2 \frac{\mathcal{G}^{\text{sl}}}{\tilde{G}}. \quad (8)$$

The assumption of a small  $m\delta$  is, however, not essential. Applying Eqs. (4) and (5) to three contiguous nonmagnetic layers [36], we find the following finite-difference equation for the spin accumulation:

$$\mathcal{D}^2 f_i^s = f_{i-1}^s - 2f_i^s + f_{i+1}^s, \quad (9)$$

where  $\mathcal{D}^2 = 2\tilde{G}^{\text{sl}}/(\tilde{G} - \tilde{G}^t)$ . The most general solution of Eq. (9) has the form

$$f_i^s = C_1 e^{\delta i} + C_2 e^{-\delta i}, \quad (10)$$

where  $\delta = \ln \{1 + (\mathcal{D}^2/2)[1 + (1 + 4/\mathcal{D}^2)^{1/2}]\}$ . This is identical to the solution of the Valet-Fert equations [32] and generalizes the definition of  $\delta$  (8) to the strong spin-flip scattering case. If the spin-flip scattering is weak, we recover Eq. (8), because  $\delta \approx \mathcal{D}$  in this limit.

Equation (8) shows that  $\delta$  is proportional not to the spin-flip scattering probability at the interface (as has usually been assumed [2]), but to its square root. Thus, for example, a seemingly large value  $\delta \approx 0.24$  deduced experimentally for the Cu/Pd interface corresponds to a spin-flip scattering probability of less than 2%.

For weak spin-flip scattering, the parameter  $\delta$  measured in multilayer ( $m \gg 1$ ) magnetoresistance experiments depends only on the sum of spin-flip transmission ( $T_{\uparrow\downarrow}$ ) and reflection ( $R_{\uparrow\downarrow}^i$ ) probabilities. These parameters are not related through unitarity, and there is no reason to assume any specific relation between them for a thin interface. In fact, spin transport in circuits containing spin-nonconserving interfaces generally depends separately on these probabilities. Therefore, the parameter  $\delta$  and the area-resistance product of the interface do not provide complete information needed for the description of arbitrary magnetoelectronic circuits.

We also note that the  $T_{\uparrow\downarrow}^{(m)}$  and  $R_{\uparrow\downarrow}^{(m)}$  components of the matrices obtained by concatenating  $m$  identical spin-nonconserving scattering matrices converge with each other when  $m$  becomes large:  $T_{\uparrow\downarrow}^{(m)} \approx R_{\uparrow\downarrow}^{(m)} \approx m(T_{\uparrow\downarrow} + R_{\uparrow\downarrow})$ . (The latter equality holds as long as  $T_{\uparrow\downarrow}^{(m)} \ll T_{\uparrow\downarrow}^{(m)}$ .) For this reason, the resistance and parameter  $\delta = t/l_{\text{sf}}$  completely describe the behavior of a sufficiently thick nonmagnetic bulk layer in an arbitrary circuit, as assumed in the Valet-Fert theory.

*First-principles calculations.*—The spin-resolved transmittances and reflectances were calculated using the

Landauer-Büttiker approach [38] implemented within the tight-binding linear muffin-tin orbital (LMTO) method [47]. The discretized representation was used for the coordinate operator in transport calculations [48], and SOC was included as a perturbation to the LMTO potential parameters [49,50]. The generalized gradient approximation is used for exchange and correlation [51].

We focus on the Cu/Pd interface, for which the experimental measurements yield a fairly large parameter  $\delta \approx 0.24$ , with relatively narrow error bars [52]. We consider (111) and (001) interface orientations, with the spin quantization axis, corresponding to the polarization of the spin current in a device, aligned either parallel or perpendicular to the interface. We assume that the atomic positions lie on the ideal face-centered cubic lattice with a lattice constant  $a = 3.818 \text{ \AA}$ . In addition to the ideal interfaces, several simple intermixing models are considered for the (111) orientation.

Some care needs to be taken to define the spin-flip scattering probabilities, bearing in mind that, owing to the presence of SOC in the bulk, the electronic states in each spin reservoir are already not pure spin-up and spin-down spinors. This bulk spin mixing should be separated from the spin-flip scattering at the interface.

To define the spin-resolved interfacial transmittance  $T_{\sigma\sigma'}$  and reflectance  $R_{\sigma\sigma'}^i$  (where  $i = \text{Cu or Pd}$ ), we turn off SOC in the leads and introduce “ramp-up” regions where SOC is gradually increased as one moves away from the embedding planes toward the Cu/Pd interface. For generic  $\mathbf{k}$  points this “adiabatic embedding” allows pure spin states in the leads to evolve without scattering into the bulk eigenstates, and the spin-dependent scattering probabilities are thus properly defined [53]. An exception occurs near the boundaries of the projections of the Fermi sheets, where the group velocity is nearly parallel to the interface. Here, the deformation of the Fermi surface by SOC can lead to strong reflection.

To examine the effect of adiabatic embedding on the Pd side, we consider a Pd slab of thickness  $D$ , located at  $|x| < D/2$  and attached to Pd leads without SOC at  $|x| > D/2$ , with the SOC parameters scaled by a function  $f(|x|)$ , such that  $f(0) = 1$  and  $f(D/2) = 0$ . We used a simple trapezoidal form of  $f(x)$ , which is constant over a few atomic layers near the interface and then declines linearly to zero; the results are insensitive to the shape of  $f(x)$ . As long as  $D$  is at least a few dozen monolayers in this test system,  $T_{\uparrow\downarrow}$  is negligible, while  $R_{\uparrow\downarrow}$  is 2–4 times smaller compared to  $R_{\uparrow\downarrow}^{\text{Pd}}$  in the Cu/Pd system with a similar ramp-up region on the Pd side. Figure 1 shows that the  $\mathbf{k}$ -resolved  $R_{\uparrow\downarrow}$  in the test system is indeed significant only near the edges of the Fermi surface projections. As expected,  $R_{\uparrow\downarrow}$  in the test Pd system quickly saturates as the width  $D$  is increased. Qualitatively, the situation is analogous to the ballistic scattering from a ferromagnetic domain wall [54].

Strong reflection near the edges of the Fermi surface projection persists in the Cu/Pd system with adiabatic embedding. Since these edges are in no way special for the

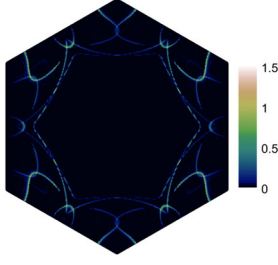


FIG. 1.  $\mathbf{k}$ -resolved spin-flip reflectance  $R_{\uparrow\downarrow}$  for the test Pd system, in which SOC is gradually suppressed away from a (111) plane. The spin quantization axis points up, parallel to the interface.

scattering from the abrupt Cu/Pd interface, it should be attributed to the reflection from the ramp-up region. Therefore, we subtract  $R_{\uparrow\downarrow}$  for the test Pd system from  $R_{\uparrow\downarrow}^{\text{Pd}}$  for the Cu/Pd interface. Since the former is a few times smaller than the latter, the uncertainties inherent in this procedure lead to relatively small errors in  $\delta$  compared to the experimental uncertainty [55].

In addition to ideal (111) and (001) interfaces, we considered several simple models of roughness with intermixing in one monolayer for the (111) interface, with the following structures of this monolayer: (A) 1:1 superlattice (50:50 model), (B)  $2 \times 2$  ordering of Pd atoms within the Cu monolayer (75:25 model), and (C)  $2 \times 2$  ordering of Cu atoms within the Pd monolayer (25:75 model).

The results are listed in Table I. Here,  $\bar{R}_{\uparrow\downarrow}^{\text{Cu}}/A$  and  $\bar{R}_{\uparrow\downarrow}^{\text{Pd}}/A$  are the specific spin-flip reflectances for Cu with SOC embedded in Cu without SOC, and for adiabatically embedded Pd with SOC, respectively. The integration is performed using a mesh of  $256 \times 256$  points in the full two-dimensional Brillouin zone; a coarser  $64 \times 64$  mesh yields very similar results. For each interface, we consider two orientations of the spin quantization axis, parallel ( $\parallel$ ) and perpendicular ( $\perp$ ) to the interface, which reflects the orientation of the spin accumulation in the device. In the parallel case, we average  $T_{\uparrow\downarrow}$  and  $R_{\uparrow\downarrow}^s$  over two orthogonal in-plane orientations of the spin quantization axis; we also average over the reversed spin indices, e.g.,  $T_{\uparrow\downarrow}$  and  $T_{\downarrow\uparrow}$ , as

well as  $T_{\uparrow\uparrow}$  and  $T_{\downarrow\downarrow}$ . The deviations from axial symmetry are appreciable only for the 50:50 model of the (111) interface, where they reach 35% for  $R_{\uparrow\downarrow}^{\text{Cu}}$ .

In all cases listed in Table I, the spin-loss conductance  $\mathcal{G}^{\text{sl}}$  is dominated by spin-flip reflection. Thus, the parameter  $\delta$  is not directly related to the probability of a spin flip in the transmission, as has been previously assumed [2].

Figure 2 shows  $\mathbf{k}$ -resolved transmittances and reflectances for the (111) interface with magnetization parallel to the interface. Note the mirror symmetry in the plane perpendicular to the spin quantization axis. Figure 2(d) shows strong reflection at the Fermi edges, similar to Fig. 1, which is due to the adiabatic embedding on the Pd side. However, contrary to Fig. 1, significant spin-flip reflection is also seen at generic  $\mathbf{k}$  points in Fig. 2(d), which originates at the Cu/Pd interface.

The values of the parameter  $\delta$  for devices with in-plane ( $\parallel$ ) spin accumulation (Table I) can be directly compared with the experimental value  $\delta = 0.24_{-0.03}^{+0.06}$  [52]. The results for (001) and (111) interface orientations are quite similar and in reasonable agreement with experiment. In agreement with Ref. [56], the calculated interface area-resistance product  $AR$  is overestimated by 65%–100% and is not strongly affected by intermixing. Intermixing also has a relatively small effect on  $\delta$ , increasing it by a small amount. Because of the fairly large size mismatch, the structure of the Cu/Pd multilayer can exhibit significant disorder and strain relaxation, which may lead to the discrepancy in the area-resistance product. The overestimation of  $\delta$  may be due to the same reason.

Table I shows that  $\delta$  becomes notably larger when the spin accumulation is oriented perpendicular to the interface. This angular dependence can be tested in experiments on multilayers [2,3] by utilizing ferromagnetic layers with perpendicular magnetization. Anisotropy of a similar kind was found for the spin-relaxation rate in thin films [15–17]. This spin relaxation is due to spin-flip reflection at the film surface, and it can also be described using the generalized circuit theory.

In conclusion, we have formulated a theory of spin loss at metallic interfaces, linking the calculable spin-dependent

TABLE I. Spin-dependent scattering at the Cu/Pd interfaces. Conductances per area are in  $\text{PS}/\text{m}^2$ ;  $2AR$  in  $\text{f}\Omega\text{m}^2$ .

Plane	Structure	M	$G_0 T_{\uparrow\uparrow}/A$	$G_0 T_{\uparrow\downarrow}/A$	$G_0 R_{\uparrow\downarrow}^{\text{Cu}}/A$	$G_0 R_{\uparrow\downarrow}^{\text{Pd}}/A$	$G_0 \bar{R}_{\uparrow\downarrow}^{\text{Cu}}/A$	$G_0 \bar{R}_{\uparrow\downarrow}^{\text{Pd}}/A$	$\mathcal{G}^{\text{sl}}/A$	$\tilde{G}/(2A)$	$2AR$	$\delta$
(001)	Ideal	$\parallel$	0.30	0.003	0.016	0.033	0.0005	0.013	0.083	0.59	1.70	0.38
		$\perp$	0.30	0.003	0.031	0.040	0.0007	0.017	0.119	0.59	1.70	0.45
(111)	Ideal	$\parallel$	0.32	0.008	0.010	0.039	0.0003	0.010	0.108	0.70	1.43	0.39
		$\perp$	0.32	0.011	0.017	0.052	0.0004	0.019	0.145	0.70	1.43	0.45
	50:50	$\parallel$	0.31	0.009	0.011	0.044	0.0003	0.010	0.125	0.66	1.51	0.43
		$\perp$	0.31	0.012	0.020	0.061	0.0004	0.019	0.173	0.66	1.51	0.51
	75:25	$\parallel$	0.31	0.010	0.011	0.048	0.0003	0.010	0.137	0.65	1.53	0.46
		$\perp$	0.31	0.014	0.020	0.067	0.0004	0.019	0.192	0.65	1.53	0.54
	25:75	$\parallel$	0.32	0.010	0.011	0.049	0.0003	0.010	0.141	0.71	1.41	0.45
		$\perp$	0.32	0.014	0.019	0.066	0.0004	0.019	0.188	0.71	1.41	0.52

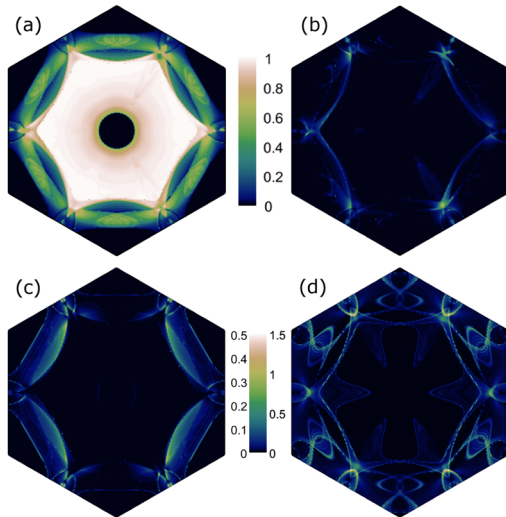


FIG. 2.  $\mathbf{k}$ -resolved transmittances  $T_{\sigma\sigma'}$  and reflectances  $R_{\sigma\sigma'}^s$  for the Cu/Pd (111) interface. (a)  $T_{\uparrow\uparrow}$ . (b)  $T_{\uparrow\downarrow}$ . (c)  $R_{\uparrow\downarrow}^{\text{Cu}}$ . (d)  $R_{\uparrow\downarrow}^{\text{Pd}}$ . The spin quantization axis points up, parallel to the interface.

scattering properties of an interface with the phenomenological parameter  $\delta$  measured in experiments on magnetoresistance in multilayers. This relation [Eq. (8)] shows that spin-flip scattering on the order of a few percent yields  $\delta$  that is comparable to unity. First-principles calculations for the Cu/Pd interface give  $\delta$  in reasonable agreement with experiment, but the value is somewhat overestimated. Understanding of spin loss at metallic interfaces is an important ingredient for the analysis of spin transport in magnetic heterostructures with strong spin-orbit coupling.

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